



TEST REPORT

for

Button Lithium-ion Cell

Model: LDA 654 13mAh (Other models see page 3 of report please)

Prepared for: DONGGUAN LIDEA ELECTRONICS CO., LTD.
Room 901, Building 2, No. 30 Fumin South Third Road, Baopi, Dalang
Town, Dongguan City, Guangdong Province, P.R. China

Prepared by: Nuocheng Safety Testing (Shenzhen) Co., Ltd.
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Report Number: NCJC240090018E1-1
Date of Test: Mar. 01, 2024 ~ Mar. 11, 2024
Date of Issue: Mar. 11, 2024

Tested By: Berry Zhao
Berry Zhao

Reported By: May Chen
May Chen

Reviewed By: Jacky Duan
Jacky Duan



The results detailed in this test report relate only to the specific sample(s) tested. It is the Application's responsibility to ensure that all production units are manufactured with equivalent EMC characteristics. This report is not to be reproduced except in full, without written approval from Nuocheng Safety Testing (Shenzhen) Co., Ltd.

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1.0 General Information**1.1 Client Information**

Application:	DONGGUAN LIDEA ELECTRONICS CO., LTD.
Address of Application:	Room 901, Building 2, No. 30 Fumin South Third Road, Baopi, Dalang Town, Dongguan City, Guangdong Province,P.R.China
Manufacturer:	DONGGUAN LIDEA ELECTRONICS CO., LTD.
Address of Manufacturer:	Room 901, Building 2, No. 30 Fumin South Third Road, Baopi, Dalang Town, Dongguan City, Guangdong Province,P.R.China

1.2 General Description of E.U.T.

Product Name:	Button Lithium-ion Cell
Model:	LDA 654 13mAh
Additional Model:	LDA 654 13mAh、LDA58100 28mAh、LDA58135 40mAh、LDA7840 20mAh、LDA7840 22mAh LDA7854 28mAh、LDA7854 30mAh、LDA870 45mAh、LDA940 30mAh、LDA954 42mAh、LDA1040 40mAh、LDA1045 46mAh、LDA1054 55mAh、LDA1070 75mAh、LDA1140 48mAh、LDA1154 65mAh、LDA1240 60mAh、LDA1240 68mAh、LDA1254 80mAh、LDA78100 62mAh、LDA78130 85mAh、LDA78150 100mAh、LDA78200 140mAh LDA78220 155mAh、LDA8558 45mAh、LDA5060 LIR1220 8mAh、LIR1620 16mAh、LIR1632 30mAh、LIR2016 16mAh LIR2025 30mAh、LIR2032 45mAh、LIR2050 60mAh、LIR2430 80mAh、LIR2040 65mAh、LIR2440 110mAh LIR2466 180mAh、LIR2450 120mAh、LIR2477 200mAh、LIR3032 110mAh、LIR3048 220mAh、LIR3540 260mAh、 LIR3548 320mAh、LIR6407mAh、LIR654 38mAh、LIR840 18mAh、LIR854 25mAh、LIR7840 15mAh、LIR7854 21mAh、LIR940 25mAh、LIR1040 38mAh、LIR1045 38mAh、LIR1054 45mAh、LIR1140 45mAh、LIR1154 50mAh、LIR1240 50mAh、LIR1254 65mAh、LIR1454 85mAh、LIR1654 110mAh
Trade Mark:	N/A
Power Supply:	3.7V, 28mAh
Memo:	N/A
Model Difference:	All models are same, except cell capacity
Remark:	N/A

1.3 Test Facility:

Name of Test Lab:	Nuocheng Safety Testing(Shenzhen) Co., Ltd.
Address of Test Lab:	2/F,No.A Building, Longxin Industrial Park, Fenghuang Third Industrial Zone ,Fuyong Street ,Baoan District,
Telephone:	+86-400-90178-907
Fax:	+86-755-23077131

2.0 List of Measurement Equipment					
Name	Model No.	Serial No.	Manufacturer	Date of Cal.	Due Date
Conducted emission					
EMI Test Receiver	ESCS30	1102.4500.30	RS	May 09, 2023	May 08, 2024
LISN	LS16C	10010947251	AFJ	May 09, 2023	May 08, 2024
Radiated emission					
EMI Test Receiver	ESVD	1026.5506.10	RS	May 09, 2023	May 08, 2024
Spectrum Analyzer	FSEM	1079.8500.30	RS	May 09, 2023	May 08, 2024
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A
Amplifier	8447D	2727A05017	HP	May 09, 2023	May 08, 2024
Bilog Antenna	VULB9163	9163/340	Schwarebeck	May 09, 2023	May 08, 2024
Harmonic & Flicker					
Harmonics Flicker Test System	PACS-1	72305	CI	May 09, 2023	May 08, 2024
5K VA AC Power source	5001iX	56060	CI	May 09, 2023	May 08, 2024
Electrostatic Discharge					
Electostatic Discharge Generator	ESD61002AG	PR12092502	Prima	May 09, 2023	May 08, 2024
Continuous radiated disturbances					
Signal Generator	2022D	119246/003	Maconi	May 09, 2023	May 08, 2024
Power Amplifier	A00181-1000	9801-112	M2S	May 09, 2023	May 08, 2024
Power Amplifier	AC8113/ 800-250A	9801-179	M2S	May 09, 2023	May 08, 2024
Power Antenna	CBL6140A	1204	SCHAFFNER	May 09, 2023	May 08, 2024
EFT/Surge/Dip					
Fast Transient Burst Simulator	EFT61004BG	PR12074375	Prima	May 09, 2023	May 08, 2024
Lightning Surge Generator	SUG61005BG	PR12125534	Prima	May 09, 2023	May 08, 2024
CYCLE SAG SIMULATOR	DRP61011AG	PR12106201	Prima	May 09, 2023	May 08, 2024
Continuous conducted disturbances					
Signal Generator	2022D	119246/003	Maconi	May 09, 2023	May 08, 2024
Power Amplifier	A00181-1000	9801-112	M2S	May 09, 2023	May 08, 2024
CDN	M3-8016	003683	MEB	May 09, 2023	May 08, 2024
Power-frequency Magnetic field					
Continuous Wave Simulator	UCS 500 M4	0304-42	EM TEST	May 09, 2023	May 08, 2024
Power Source Network	MV 2616	0104-14	EM TEST	May 09, 2023	May 08, 2024
Current Transformer	MC2630	--	EM TEST	May 09, 2023	May 08, 2024

Magnetic Coil	MS100	0304-42	EM TEST	May 09, 2023	May 08, 2024
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3.0 Technical Details

3.1 Investigations Requested

Perform Electromagnetic Interference [EMI] & Electromagnetic Susceptibility [EMS] tests for CE Marking

3.2 Test Standards

EN55032:2015/A11:2020	Limits and methods of measurement of radio disturbance characteristics for information technology equipment
EN IEC 61000-3-2:2019+A1:2021	Electromagnetic compatibility(EMC)- Part 3-2:Limits-Limits for harmonic current emissions(equipment input current $\leq 16A$ per phase)
EN 61000-3-3: 2013+A1:2019	Electromagnetic compatibility (EMC)- Part 3-3:Limits-Limitation of voltage changes, Voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current $\leq 16A$ per phase and not subject to conditional connection
EN 55035:2017/A11:2020	Electromagnetic Compatibility Generic Immunity Standard, Part 1: Residential, Commercial and Light Industry.

3.3 Performance Criteria

- Criterion A During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed.
- Criterion B During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.
- Criterion C During and after testing, temporary loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls or cycling of the power to the EUT by the user in accordance with the manufacturer's instructions.
- Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

3.4 Test standards and Results Summary Tables

Test Condition	Test Requirement	Test Method	Test Result
EMISSION Results Summary			
Conducted Emission on AC Mains, 150KHz to 30MHz	EN 55032:2015/A11:2020	EN 55032:2015/A11:2020	N/A
Conducted Emission on at telecommunication ports, 150KHz to 30MHz	EN 55032:2015/A11:2020	EN 55032:2015/A11:2020	N/A
Radiated Emissions, 30MHz to 1GHz	EN 55032:2015/A11:2020	EN 55032:2015/A11:2020	Pass
Harmonic Emissions on AC supply	EN IEC 61000-3-2:2019+A1:2021	EN IEC 61000-3-2:2019+A1:2021	N/A
Voltage fluctuations on AC supply	EN 61000-3-3:2013+A1:2019	EN 61000-3-3:2013+A1:2019	N/A
IMMUNITY Results Summary			
Electrostatic Discharge	EN 55035:2017/A11:2020	EN 61000-4-2: 2009	Pass
RF field strength susceptibility	EN 55035:2017/A11:2020	EN 61000-4-3: 2010	N/A
Electrical Fast transients /Burst Immunity	EN 55035:2017/A11:2020	EN 61000-4-4:2004+A1:2010	N/A
Surge	EN 55035:2017/A11:2020	EN 61000-4-5: 2006	N/A
Conducted susceptibility	EN 55035:2017/A11:2020	EN 61000-4-6: 2009	N/A
Power-frequency Magnetic Field	EN 55035:2017/A11:2020	EN 61000-4-8:2010	N/A
Dips/Voltage Interruption Variation	EN 55035:2017/A11:2020	EN 61000-4-11: 2004	N/A

Note: N/A=Not applicable

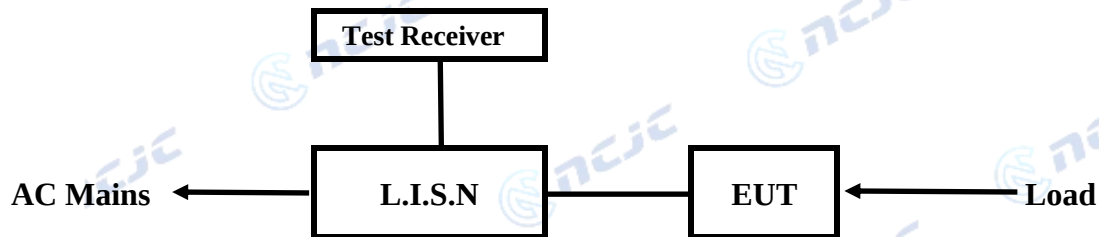
3.5 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	MU
1.	Temperature	$\pm 0.1^{\circ}\text{C}$
2.	Humidity	$\pm 1.0\%$
3.	Spurious emissions, conducted	$\pm 3.70\text{dB}$
4.	All emissions, radiated	$\pm 4.50\text{dB}$

4.0 Electromagnetic Interference Test results

4.1 Power Line Conducted Emission Test

4.1.1 Schematics of the test



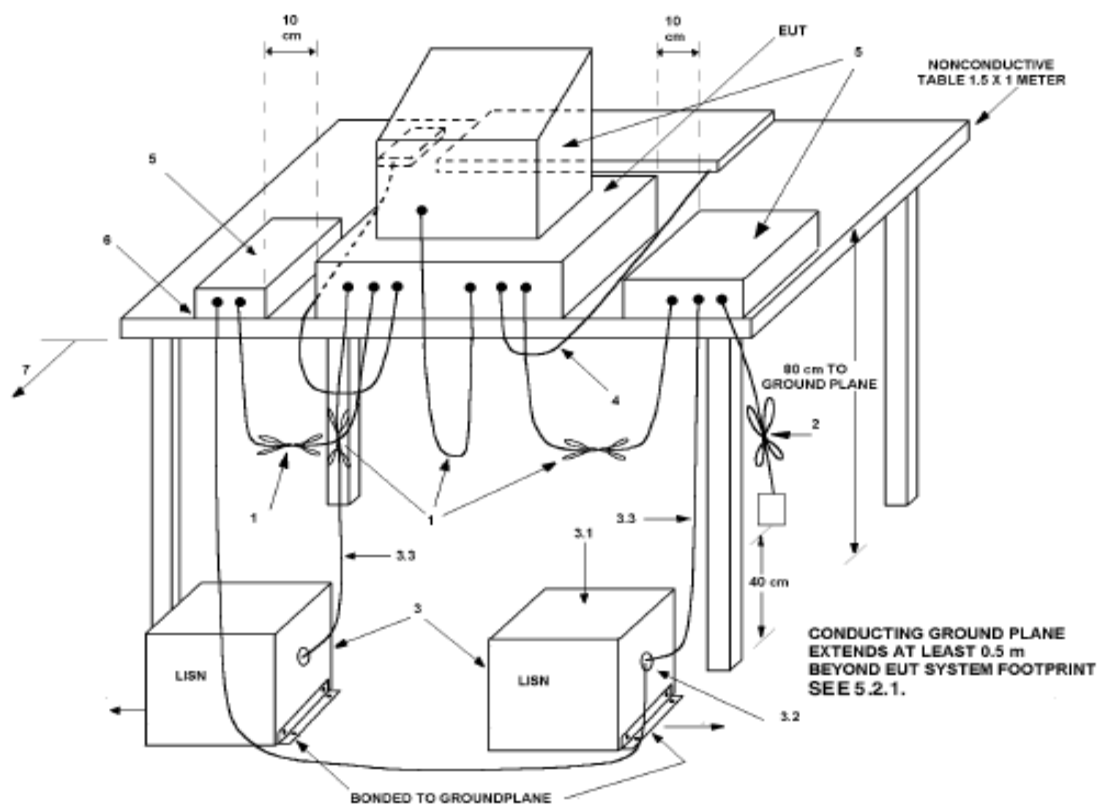
EUT: Equipment Under Test

4.1.2 Test Method and test Procedure

The test was performed in accordance with EN 55032:2015/A11:2020

Test Voltage: 230V~, 50Hz

Block diagram of Test setup



4.1.3 EUT Operating Condition

Operating condition is according to EN 55032:2015/A11:2020

Setup the EUT and simulators as shown on the following

4.1.4 Test Equipment

Please refer to the Section 2

4.1.5 Power line conducted Emission Limit

Frequency(MHz)	Class A Limits (dBμV)		Class B Limits (dBμV)	
	Quasi-peak Level	Average Level	Quasi-peak Level	Average Level
0.15 ~ 0.50	79.0	66.0	66.0~56.0*	56.0~46.0*
0.50 ~ 5.00	73.0	60.0	56.0	46.0
5.00 ~ 30.00	73.0	60.0	60.0	50.0

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The tighter limit shall apply at the transition frequencies

4.1.6 Photo documentation of the test set-up

Please refer to the Section 7

4.1.7 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 50% Atmospheric pressure: 103kPa

Frequency range: 0.15 MHz – 30 MHz

4.1.8 Test result :

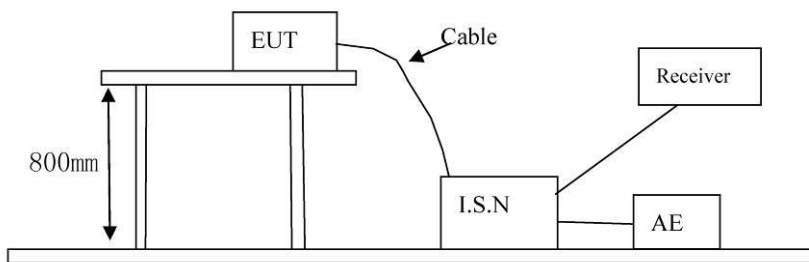
The requirements are FULFILLED

Remarks: According to the EN 55032:2015/A11:2020

A Conducted Emission on Live Terminal of the power line (150kHz to 30MHz)

B Conducted Emission on Neutral Terminal of the power line (150kHz to 30MHz)

4.2.1 Test Method: The test was performed in accordance with EN 55032:2015/A11:2020



4.2.2 EUT Operating Condition

Operating condition is according to EN 55032:2015/A11:2020

4.2.3 Test Equipment

Please refer to the Section 2

4.2.4 Power line conducted Emission Limit

Frequency(MHz)	Class A Limits (dBμV)		Class B Limits (dBμV)	
	Quasi-peak Level	Average Level	Quasi-peak Level	Average Level
0.15 ~ 0.50	97 to 87	84 to 74	84 to 74	74 to 64
0.50 ~ 30.00	87	74	74	64

- Notes:
- *Decreasing linearly with logarithm of frequency.
 - The tighter limit shall apply at the transition frequencies

4.2.5 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 50% Atmospheric pressure: 103kPa

Frequency range: 0.15 MHz – 30 MHz

4.2.6 Test result

The requirements are FULFILLED

Remarks: According to the EN 55032:2015/A11:2020

A Conducted Emission on Telecommunication port (150kHz to 30MHz)

EUT Description: --

Operation Mode: --

Tested By: --

Test date: --

Test Result: --

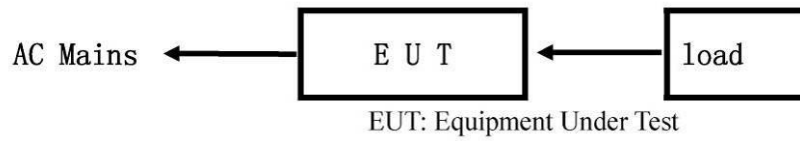
Start Frequency	Stop Frequency	Step	IF BW	Detector	Final M-Time
0.15MHz	30MHz	4.5KHz	10KHz	QP+AV	1s

Frequency (MHz)	Port	Reading(dBμA)		Limit(dBμA)	
		Quasi-peak	Average	Quasi-peak	Average

Remark: The test item is not applicable.

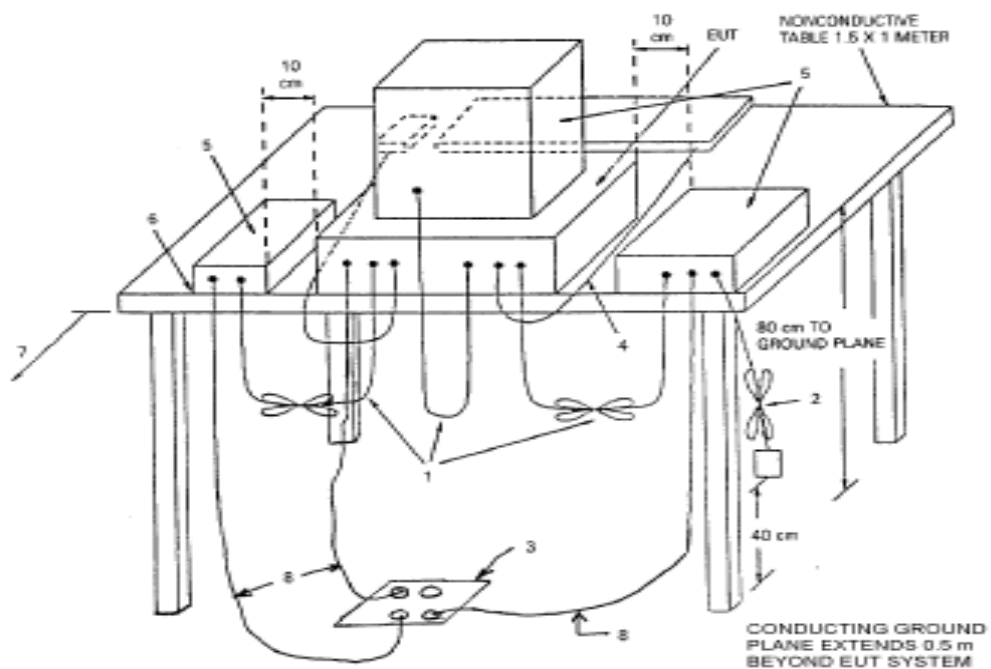
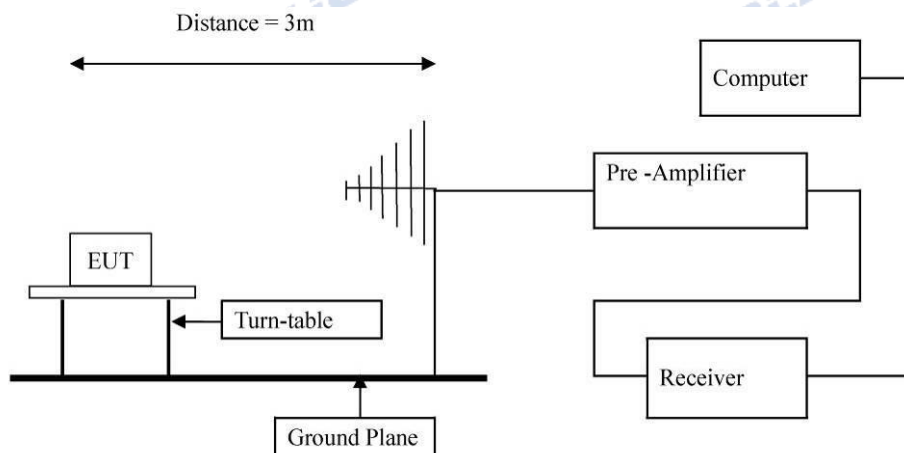
4.3 Radiated Emission Test

4.3.1 Schematics of the test



4.3.2 Test Method: The test was performed in accordance with EN 55032:2015/A11:2020

Block diagram of Test setup



4.3.3 EUT Operating Condition

Operating condition is according to EN 55032:2015/A11:2020

4.3.4 Radiated Emission Limit

All emission from a digital device, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strength specified below:

Frequency Range (MHz)	Distance (m)	Quasi-Peak limits (dB μ V/m)	
		Class A Limits	Class B Limits
30-230	3	50.00	40.00
230-1000	3	57.00	47.00

Note: 1) The lower limit shall apply at the transition frequencies

2) If measurement is not made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula $L_{d1} = L_{d2} * (d_2/d_1)$

4.3.5 Photo documentation of the test set-up

Please refer to the Section 7

4.3.6 Test Equipment:

Please refer to the Section 2

4.3.7 Test specification:

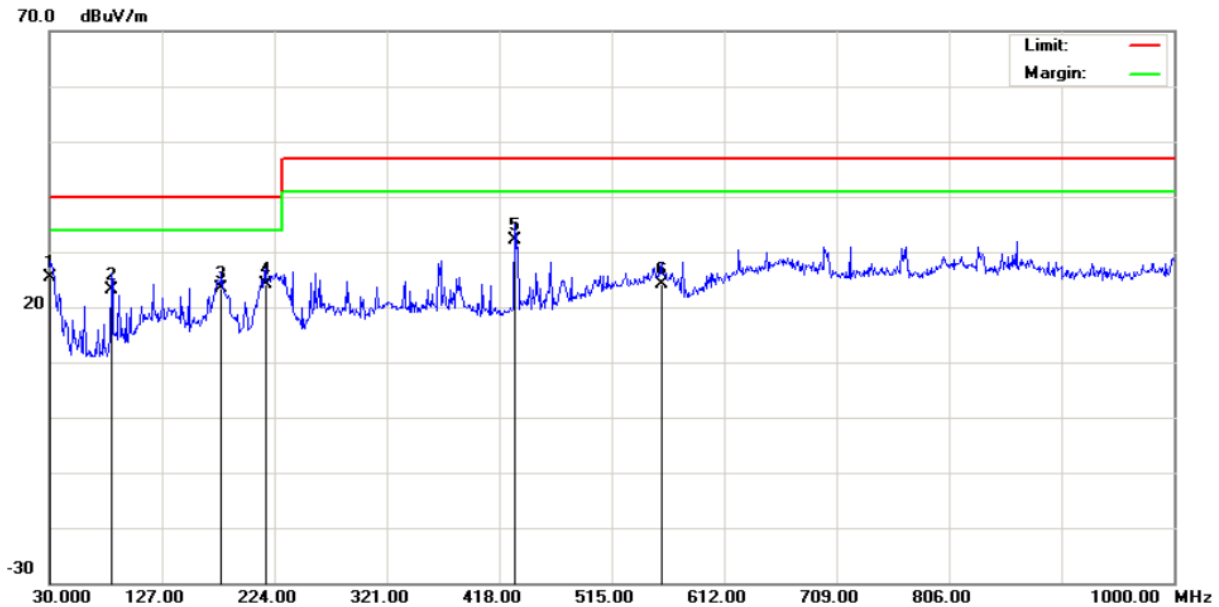
Environmental conditions: Temperature 26 °C Humidity: 56% Atmospheric pressure: 103kPa

4.3.8 Test result

The requirements are FULFILLED

Remarks: According to the EN 55032:2015/A11:2020

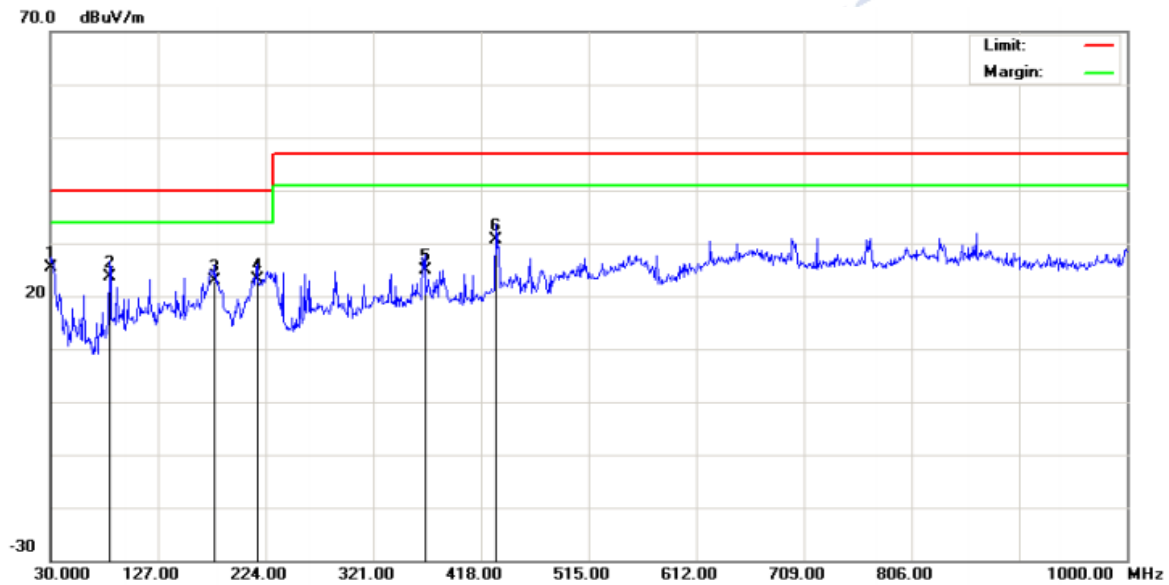
A. Radiated Emission In Horizontal (30MHz----1000MHz)



Radiated Emission Test
Test Site : 3m chamber
Env. Cond. : Temp.: 24.2°C Humi.: 55% Pressure: 101.3kPa
Polarity : HORIZONTAL
Limit : EN55032 CLASS B

No.	Mk.	Freq.	Reading	Correct	Measure-	Limit	Over	Antenna	Table	
		MHz	Level	Factor	ment			Height	Degree	
			dBuV	dB	dBuV/m	dBuV/m	dB	cm	degree	Comment
1	*	30.9700	21.50	3.95	25.45	40.00	-14.55	QP		
2		83.3500	34.49	-11.47	23.02	40.00	-16.98	QP		
3		178.4100	28.30	-4.85	23.45	40.00	-16.55	QP		
4		216.2400	30.56	-6.35	24.21	40.00	-15.79	QP		
5		431.5800	35.98	-3.79	32.19	47.00	-14.81	QP		
6		557.6800	21.31	2.89	24.20	47.00	-22.80	QP		

B. Radiated Emission In Vertical (30MHz----1000MHz)



Radiated Emission Test
Test Site : 3m chamber
Env. Cond. : Temp.: 24.2°C Humi.: 55% Pressure: 101.3kPa
Polarity : VERTICAL
Limit : EN55032 CLASS B

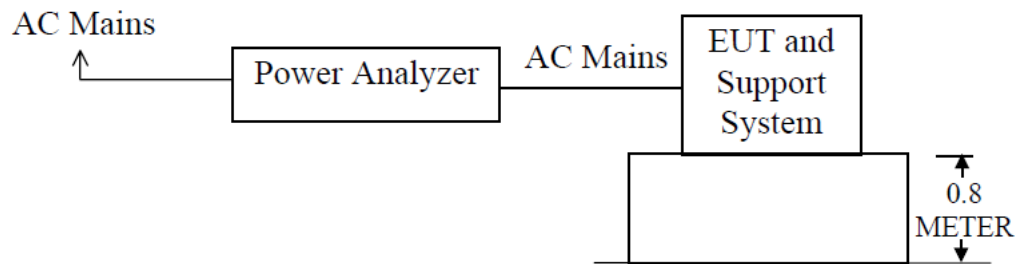
No.	Mk.	Freq.	Reading Level	Correct Factor	Measurement	Limit	Over	Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	cm	degree	Comment
1	*	30.9697	21.50	3.95	25.45	40.00	-14.55	QP		
2		83.3499	34.99	-11.47	23.52	40.00	-16.48	QP		
3		178.4097	27.80	-4.85	22.95	40.00	-17.05	QP		
4		216.2400	29.56	-6.35	23.21	40.00	-16.79	QP		
5		367.5600	27.52	-2.66	24.86	47.00	-22.14	QP		
6		431.5799	34.48	-3.79	30.69	47.00	-16.31	QP		

4.4 Harmonic Current Emissions

4.4.1 EUT Operating Mode

--

4.4.2 Block Diagram of Test Setup.



This test was performed as per EMC Basic Standard EN IEC 61000-3-2:2019+A1:2021 Class A

4.4.3 Test Equipment

Please refer to Section 2 this report.

4.4.4 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 54% Atmospheric pressure: 103kPa

4.4.5 Results

Port	EUT Operating mode	Result (Passed / Failed)
AC Input	Full load	Pass

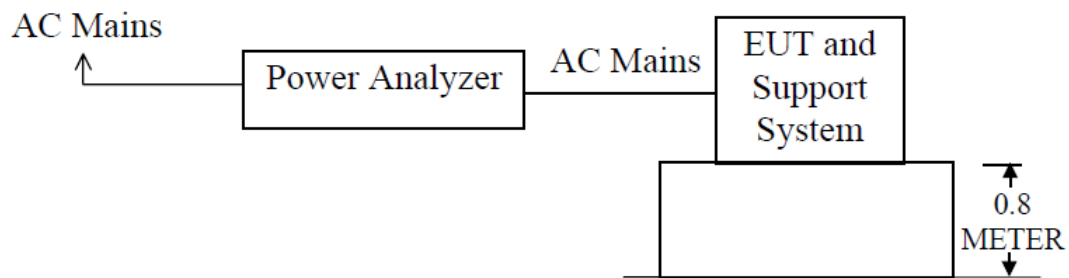
Remark:

4.5 Flicker and Voltage Fluctuation

4.5.1 EUT Operating Mode

Load

4.5.2 Block Diagram of Test Setup.



This test was performed as per EMC Basic Standard EN EN 61000-3-3:2013+A1:2019

4.5.3 Limits of Voltage Fluctuation and Flicks Measurement

Test Item	Limit	Note
P_{st}	1.0	Pst means short-term flicker indicator
P_{lt}	0.65	Plt means long-term flicker indicator
T_{dt} (ms)	200	Tdt means maximum time that dt exceeds 3%.
d_{max} (%)	4	Dmax means maximum relative voltage change.
dc (%)	3	Dc means relative steady-state voltage change.

4.5.4 Test Equipment

Please refer to Section 2 this report.

4.5.5 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 54% Atmospheric pressure: 103kPa

4.5.6 Results

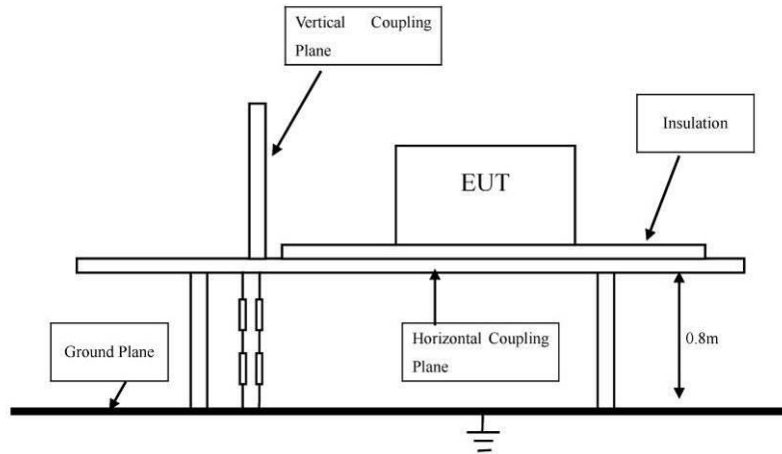
Port	EUT Operating mode	Result (Passed / Failed)
AC Input	Full load	Pass

Remark:

5.0 Immunity Test

5.1 Electrostatic Discharge

5.1.1 Schematic of the test



5.1.2 Test method

The test was performed in accordance with EN 61000-4-2

5.1.3 Test severity

±4kV for direct & in-direct Contact Discharge

±8kV for air Discharge

Performance Criterion Require: **B**

5.1.4 Test Equipment

Please refer to Section 2 this report.

5.1.5 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 54% Atmospheric pressure: 103kPa

5.1.6 Operation mode: Discharging Mode

5.1.7 Discharge location

- HCP
- VCP
- Shell
- USB Port

5.1.8 Test Result

Pass

5.2 RF field strength susceptibility (80MHz----- 1000MHz)

5.2.1 Test Method:

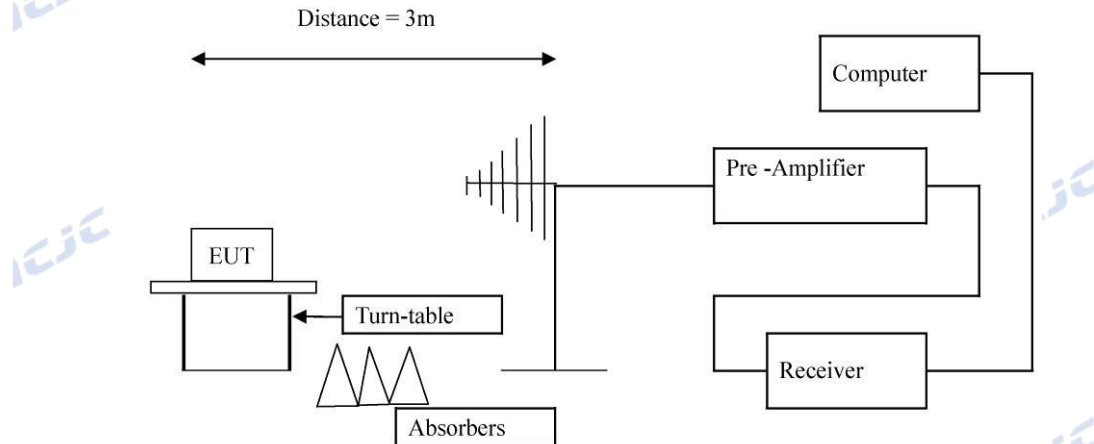
The test was performed in accordance with EN 61000-4-3

Severity: Level 2 (3V/m)

Modulation: 1 KHz 80% AM

Performance Criterion Require: A

Block diagram of Test setup



5.2.2 Test Equipment

Please refer to Section 2 this report.

5.2.3 Test specification:

Environmental conditions: Temperature: 25 °C Humidity: 54% Atmospheric pressure: 103kPa

5.2.4 Operation mode: Discharging Mode

5.2.5 Test Result:

Please refer to the following table for individual results.

Frequency (MHz)	Radiation to	Polarity	Level (V/m)	Dwell Time(s)	Sweep Rate (%)	Results
80-1000	Front	Horizontal	3	1	1	Pass
80-1000	Rear	Horizontal	3	1	1	Pass
80-1000	Left	Horizontal	3	1	1	Pass
80-1000	Right	Horizontal	3	1	1	Pass
80-1000	Front	Vertical	3	1	1	Pass
80-1000	Rear	Vertical	3	1	1	Pass
80-1000	Left	Vertical	3	1	1	Pass
80-1000	Right	Vertical	3	1	1	Pass

5.3 Electrical Fast Transient/Burst (EFT/B) immunity test

5.3.1 Schematics of the test



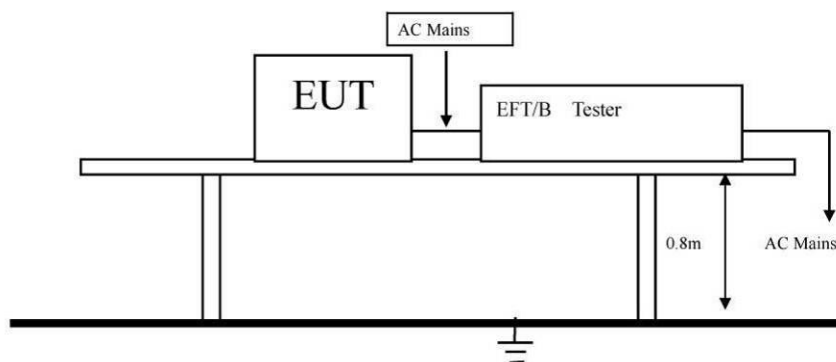
5.3.2 Test Method

The test was performed in accordance with EN 61000-4-4

Severity: Level 2 (1kV)

Performance Criterion Require: **B**

Block diagram of Test setup



5.3.3 Test Equipment

Please refer to Section 2 this report.

5.3.4 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 54% Atmospheric pressure: 103kPa

5.3.5 Operation mode: Full Load

5.3.6 Test Results

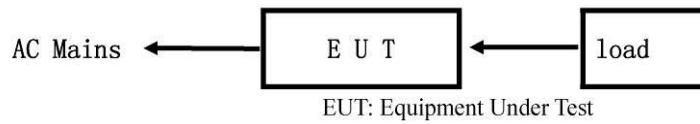
Inject location: AC mains

Inject Line	Voltage kV	Inject Times (s)	Method	Results
L	± 1	120	Direct	Pass
N	± 1	120	Direct	Pass
L、N	± 1	120	Direct	Pass
E	± 1	120	Direct	N/A
L、E	± 1	120	Direct	N/A
N、E	± 1	120	Direct	N/A
L、N、E	± 1	120	Direct	N/A

Remark:

5.4 Surge test

5.4.1 Schematics of the test



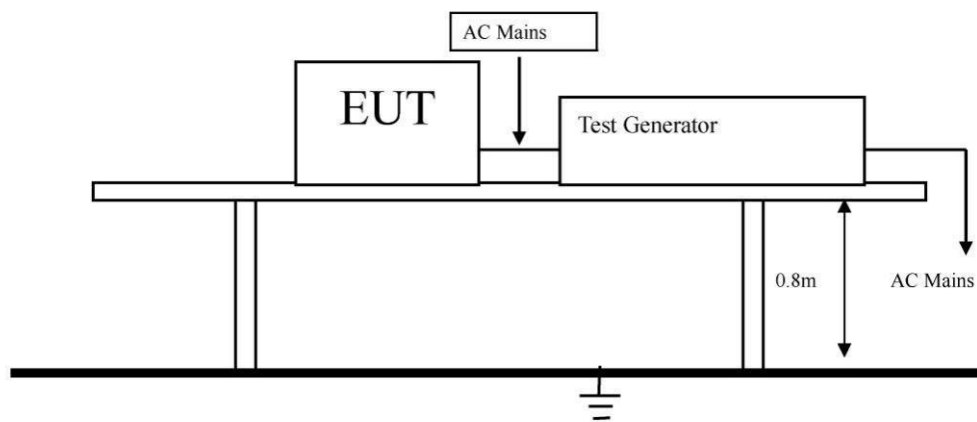
5.4.2 Test Method:

The test was performed in accordance with EN 61000-4-5

Severity: Level 2

Performance Criterion Require: B

Block diagram of Test setup



5.4.3 Test Equipment

Please refer to Section 2 this report.

5.4.4 Test specification:

Environmental conditions: Temperature: 22 °C Humidity: 54% Atmospheric pressure: 103kPa

5.4.5 Operation mode: Full Load

5.4.6 Test Results

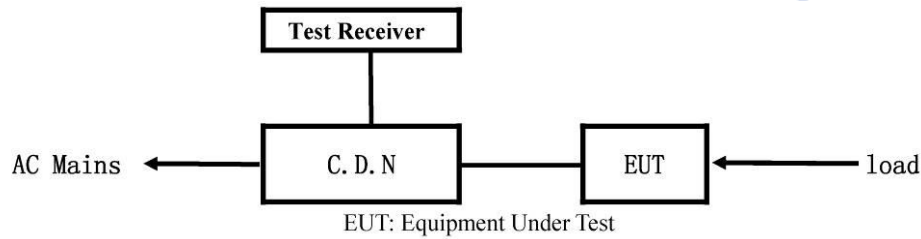
5 pulses for each polarity and test voltage, and repetition rate is 1 per min.

Location	Polarity	0°	90°	180°	270°	Results
L-N	± 1 KV	N/A	N/A	N/A	N/A	Pass
L-PE	± 2 KV	N/A	N/A	N/A	N/A	Pass
N-PE	± 2 KV	N/A	N/A	N/A	N/A	Pass

Remark:

5.5 Conducted Immunity test

5.5.1 Schematics of the test



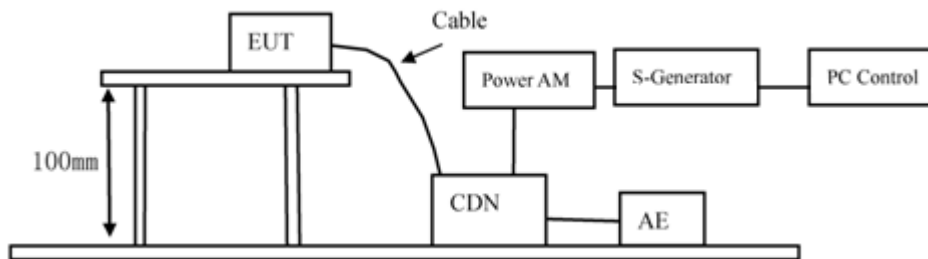
5.5.2 Test Method

The test was performed in accordance with EN 61000-4-6

Severity: Level 2 (3 V rms), 0.15MHz—80MHz

Performance Criterion Require: A

Block diagram of Test setup



5.5.3 Test Equipment

Please refer to Section 2 this report.

5.5.4 Test specification:

Environmental conditions: Temperature: 23 °C Humidity: 54% Atmospheric pressure: 103kPa

5.5.5 Operation mode: Full Load

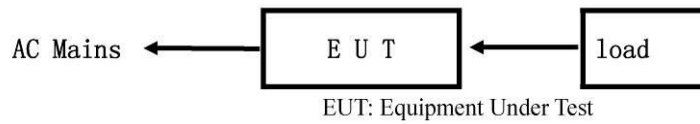
5.5.6 Test Results:

Frequency Range (MHz)	Injected Position	Strength	Criterion	Result
0.15 - 80	AC Line	3V (rms) Unmodulated	A	Pass

Remark:

5.6 Power-Frequency magnetic field test

5.6.1 Schematics of the test



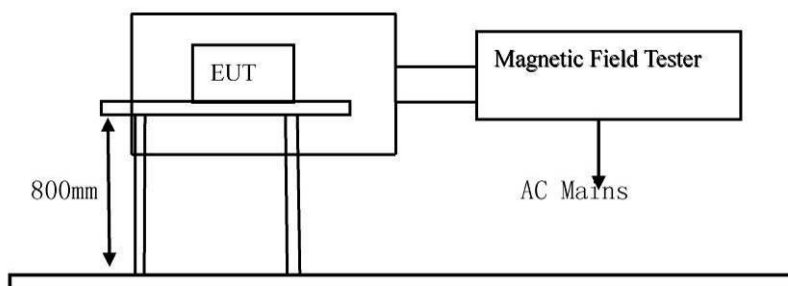
5.6.2 Test Method

The test was performed in accordance with EN 61000-4-8

Severity: Level 1 (1A/m),

Performance Criterion Require: A

Block diagram of Test setup



5.6.3 Test Equipment

Please refer to Section 2 this report.

5.6.4 Test specification:

Environmental conditions: Temperature: 22 °C Humidity: 54% Atmospheric pressure: 103kPa

5.6.5 Operation mode:

--

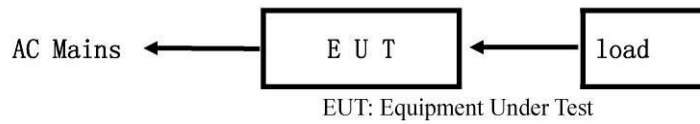
5.6.6 Test Results:

Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 Mins	X	A	N/A
1A/m	5 Mins	Y	A	N/A
1A/m	5 Mins	Z	A	N/A

Remark: The test item is not applicable.

5.7 Voltage Dips/Interruptions immunity test

5.7.1 Schematics of the test

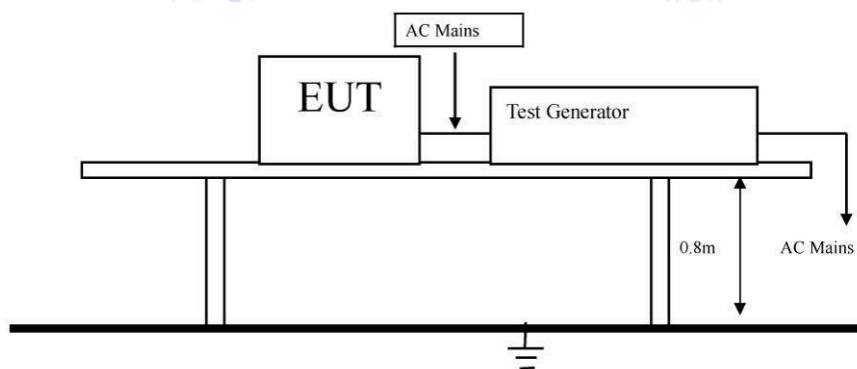


5.7.2 Test Method:

The test was performed in accordance with EN 61000-4-11

Performance Criterion Require: C&B

Block diagram of Test setup



5.7.3 Test Equipment

Please refer to Section 2 this report.

5.7.4 Test specification:

Environmental conditions: Temperature: 22 °C Humidity: 54% Atmospheric pressure: 103kPa

5.7.5 Operation mode: Full load

5.7.6 Test Result:

Voltage Dip: Voltage Interceptions:

Test Level % Ut	Reduction	Duration (periods)	Phase Angle	Meet Criterion	Result
0	100	0.5	0° - 360°	B	Pass
70	30	25	0° - 360°	C	Pass
0	100	250	0° - 360°	C	Pass

Remark:

6.0 CE Label

6.1 label specification

Text of the mark is black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.

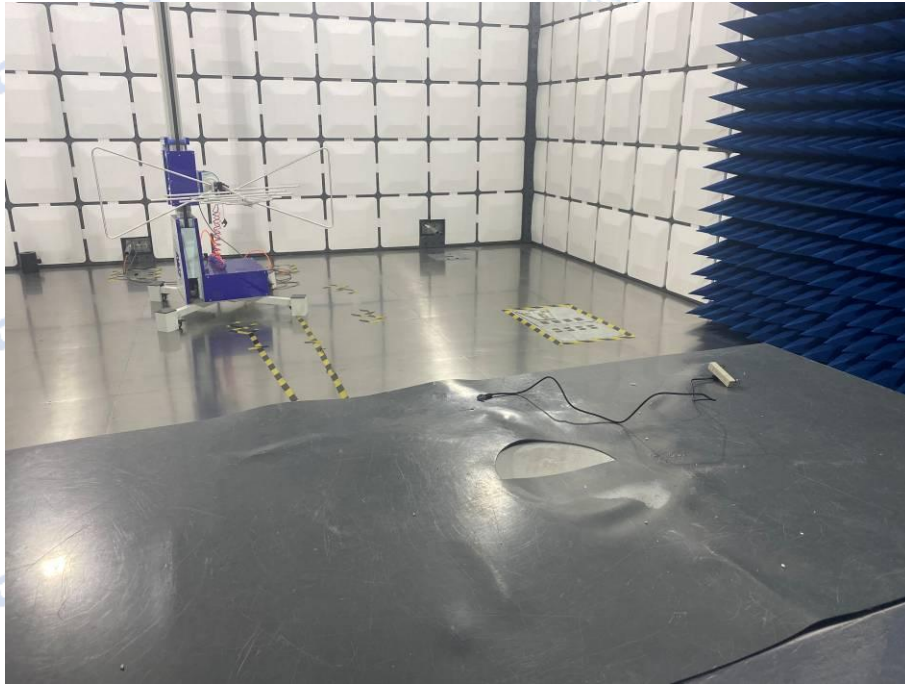


6.2 Mark Location: On the product body

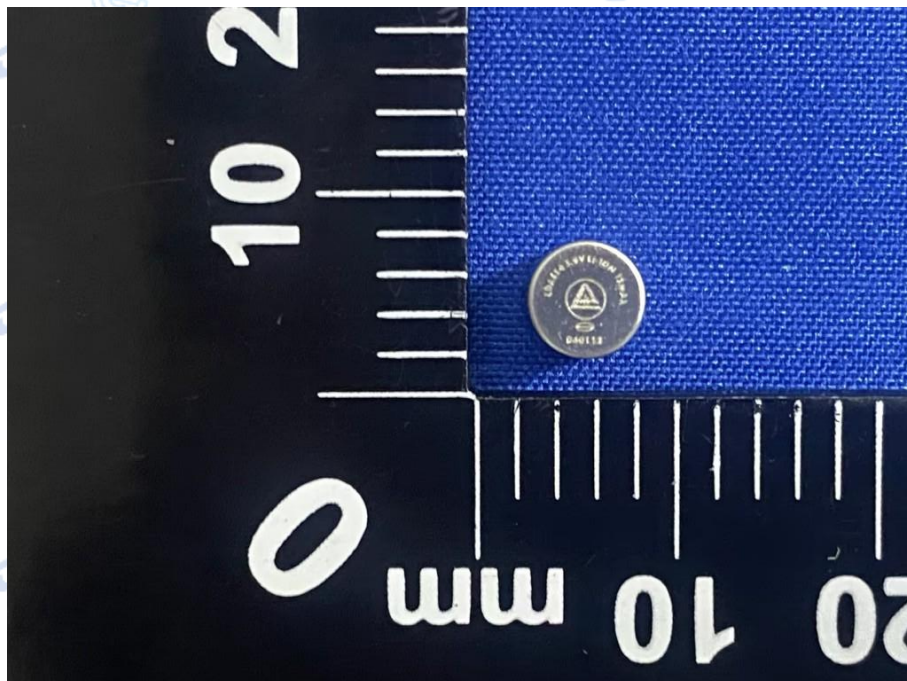
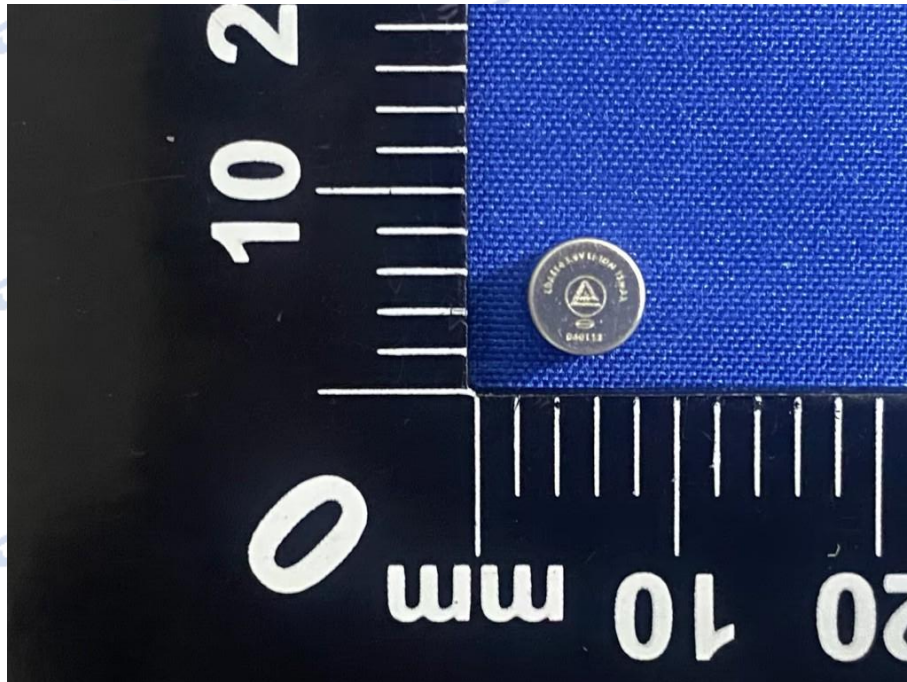
7.0 Photos of testing

Conducted Emission Test View

Radiated Emission Test View



8.0 Photos of the EUT



--End of the report--